

Absolute Maximum Ratings Over Operating Free-Air Temperature (unless otherwise noted)[†]

Supply Voltage Range, VDD ⁽¹⁾	-0.5V to 4V
Voltage Range:	Enables or R _{OUT} -0.5V to V _{DD} +2V
R _{IN+} or R _{IN-}	-0.5V to 4V
Electrostatic Discharge ⁽²⁾ :	
R _{IN+} , R _{IN-} , and GND	Class 3, A: 10kV, B: 700V
All Pins	Class 3, A: 8kV, B: 600V
Storage Temperature Range	-65°C to 150°C
Lead Temperature 1,6mm(1/16 inch) from case for 10 seconds	260°C

[†] Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "Recommended Operating Conditions" is not implied. Exposure to Absolute-Maximum-Rated conditions for extended periods may affect device reliability.

Notes:

1. All voltage values, except differential I/O bus voltages, are with respect to ground terminal.
2. Tested in accordance with MIL-STD-883C Method 3015.7

Function Table

Differential Input	Enables	Output
R _{IN} ±	EN	R _{OUT}
V _{ID} ≥ 100mV	H	H
-100mV < V _{ID} ≤ 100mV	H	?
V _{ID} ≤ -100mV	H	L
X	L	Z
Open	H	H
X	H	R _{OUT0}

Notes:

H = high level, L = low level, X = irrelevant
Z = high impedance (off), ? = indeterminate

Recommended Operating Conditions

	Min.	Nom.	Max.	Units	
Supply Voltage, V _{CC}	3.0	3.3	3.6	V	
High-Level Input Voltage, V _{IH}	2.0				
Low-Level Input Voltage, V _{IL}			0.8		
Magnitude of Differential Input Voltage V _{ID}	0.1		0.6		
Common-Mode input Voltage, V _{IC}	$\frac{ V_{ID} }{2}$		$2.4 - \frac{ V_{ID} }{2}$		
			V _{CC} - 0.8		
Operating free-air temperature, T _A	-40		85	°C	

Electrical Characteristics Over Recommended Operating Conditions (unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ. ⁽¹⁾	Max.	Units
V _I TH+	Positive-going differential input voltage threshold				100	mV
V _I TH-	Negative-going differential input voltage threshold		-100			
V _{OH}	High-level output voltage	I _{OH} = -8mA	2.4	3.1		V
V _{OL}	Low-level output voltage	I _{OL} = 8mA		0.3	0.45	
I _{CC}	Supply Current	Enabled, No load		40	56	mA
		Disabled			3	
I _I	Input Current (R _{IN+} or R _{IN-} inputs)	LV	V _I = 0V			-20
			V _I = 2.4V	-1.2		
		LVT	V _I = 0V, other input open			-40
			V _I = 2.4V, other input open	-2.4		
I _I (OFF)	Power-off input current (R _{IN+} or R _{IN-} inputs)	V _{CC} = 0V, V _I = 2.4V		12	±20	µA
I _{IH}	High-level input current (enables)	V _{IH} = 2V				10
I _{IL}	Low-level input current (enables)	V _{IL} = 0.8V				
I _{OZ}	High-impedance output current	V _O = 0V			±1	
		V _O = 3.6V			10	
C _{IN}	Input capacitance (R _{IN+} or R _{IN-} inputs to GND)	V _{ID} = 0.4 sin 2.5E09 t V		6		pF
Z _(t)	Termination Impedance (LVT)			88	110	143

Note:

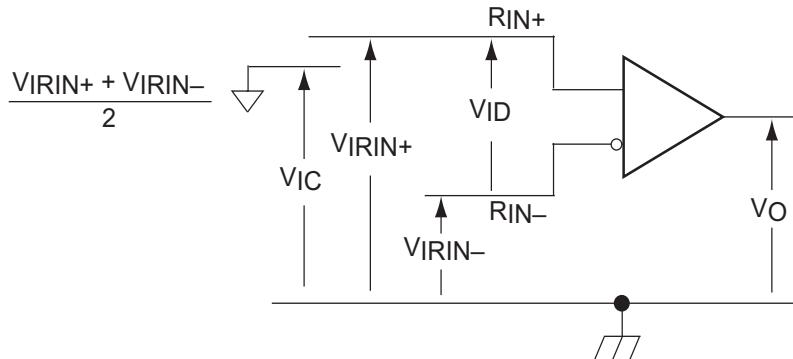
1. All typical values are at 25°C and with a 3.3V supply.

Switching Characteristics Over Recommended Operating Conditions (unless otherwise noted)

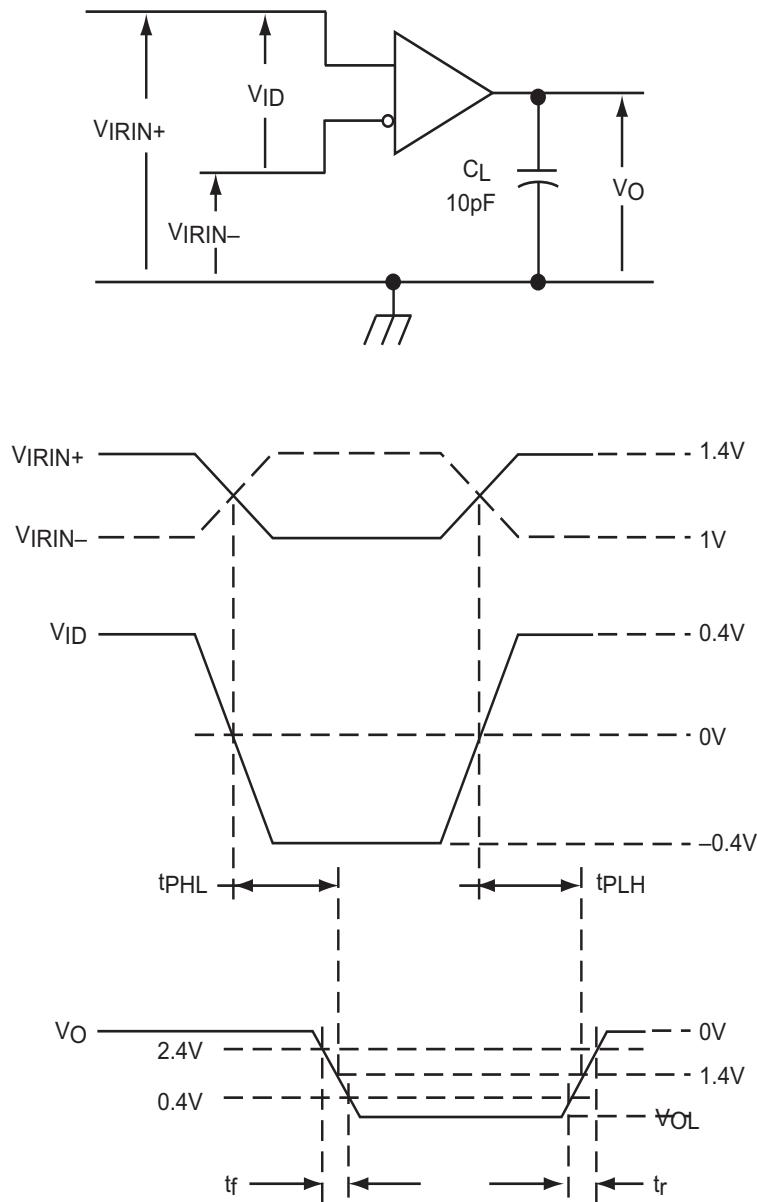
Symbol	Parameter	Test Conditions	Min.	Typ. ⁽¹⁾	Max.	Units
t _{PLH}	Propagation delay time, low-to-high-level output	See Figure 2	1	2.2	3.1	ns
t _{PHL}	Propagation delay time, high-to-low-level output		1	2.1	3.1	
t _r	Differential output signal rise time		500	900	1500	ps
t _f	Differential output signal fall time		500	820	1200	
t _{sk(p)}	Pulse skew (t _{PHL} – t _{PLH})			120	244	
t _{sk(o)}	Output skew ⁽²⁾			180	320	
t _{sk(pp)}	Part-to-part skew ⁽³⁾				1	
t _{PZH}	Propagation delay time, high-impedance-to-high-level output	See Figure 3 ⁽⁴⁾		2.5	3.7	ns
t _{PZL}	Propagation delay time, high-impedance-to-low-level output			4.8	6.7	
t _{PHZ}	Propagation delay time, high-level-to-high-impedance output			3.7	5.3	
t _{PLZ}	Propagation delay time, low-level-to-high-impedance output			6.4	8.7	
f _{MAX}	Maximum Clock frequency		300			MHz

Notes:

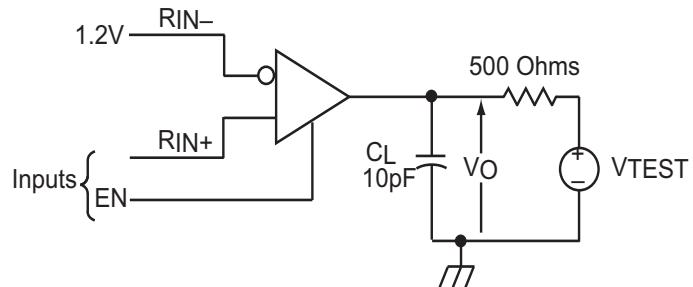
1. All typical values are at 25°C and with a 3.3V supply
2. t_{sk(o)} is the magnitude of the time difference between the t_{PLH} or t_{PHL} of all drivers of a single device with all of their inputs connected together.
3. t_{sk(pp)} is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.
4. ROUT0 disable time is 1 nanosecond greater.

Parameter Measurement Information

Figure 1. Voltage Definitions
Table 1. Receiver Minimum and Maximum Input Threshold Test Voltages

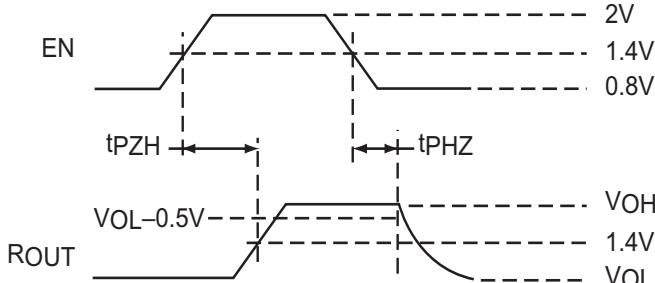
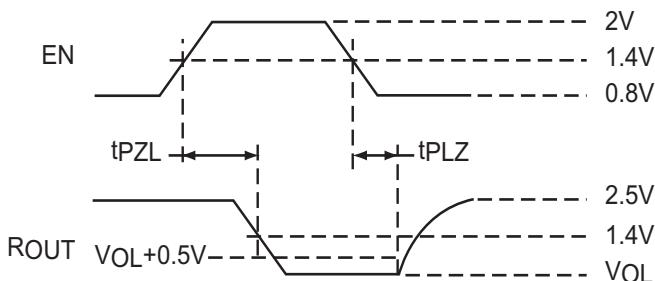
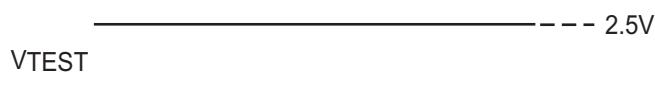
Applied Voltages		Resulting Differential Input Voltage	Resulting Common-Mode Input Voltage
V_{IRIN+}	V_{IRIN-}	V_{ID}	V_{IC}
1.25V	1.15V	100mV	1.2V
1.15V	1.25V	-100mV	1.2V
2.4V	2.3V	100mV	2.35V
2.3V	2.4V	-100mV	2.35V
0.1V	0V	100mV	0.05V
0V	0.1V	-100mV	0.05V
1.5V	0.9V	600mV	1.2V
0.9V	1.5V	-600mV	1.2V
2.4V	1.8V	600mV	2.1V
1.8V	2.4V	-600mV	2.1V
0.6V	0V	600mV	0.3V
0V	0.6V	-600mV	0.3V

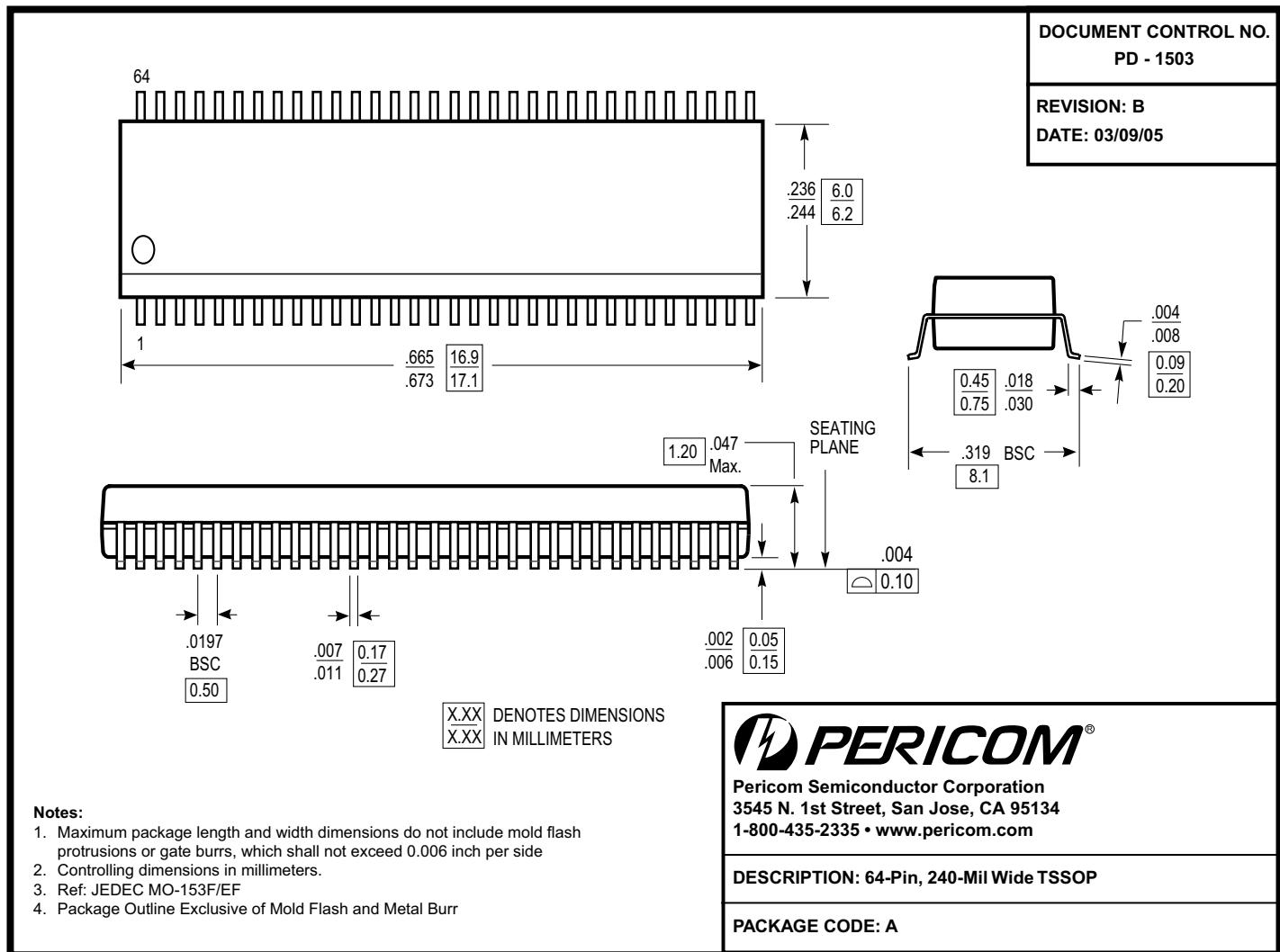
Parameter Measurement Information

Figure 2. Timing Test Circuit and Waveforms
Note:

1. All input pulses are supplied by a generator having the following characteristics: t_f or $t_r \leq 1\text{ns}$, Pulse Repetition Rate (PRR) = 50 Mpps, Pulse width = $10 \pm 0.2\text{ns}$. C_L includes instrumentation and fixture capacitance within 0.06m of the D.U.T.

Parameter Measurement Information

Note:

1. All input pulses are supplied by a generator having the following characteristics: t_r or $t_f \leq 1\text{ns}$, Pulse Repetition Rate (PRR) = 0.5 Mpps, pulse width = $500 \pm 10\text{ns}$. C_L includes instrumentation and fixture capacitance within 0.06m of the D.U.T.


Figure 3. Enable/Disable Test Circuit and Waveforms

Packaging Mechanical: 64-Pin TSSOP (A)

Ordering Information

Ordering Code	Package Code	Package Type
PI90LV386AE	A	Pb-free & Green, 64-pin TSSOP
PI90LVT386AE	A	Pb-free & Green, 64-pin TSSOP

Notes:

1. Thermal characteristics can be found on the company web site at www.pericom.com/packaging/
2. X = Tape and reel